


<b>Search Notes</b> 	<b>Application/Control No.</b> 10518451	<b>Applicant(s)/Patent Under Reexamination</b> BAE ET AL.
	<b>Examiner</b> Bui, Luan K	<b>Art Unit</b> 3728

SEARCHED			
Class	Subclass	Date	Examiner
206	389,395,397,407-409	3/28/07	lkb
220	611,612,615,616,622,625,634-636,646		
229	4.5,5.5,5.7,93,122.3,122.31		
242	170-174,129,134,137,588.4,588.6		

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner